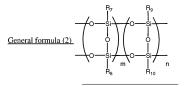
IN THE CLAIMS:

Please cancel Claims 2, 3, and 11 to 37 without prejudice to or disclaimer of the subject matter presented therein. Please amend Claims 1 and 4 to 10 as shown below.

 (Currently Amended) A field effect transistor having an organic semiconductor layer, comprising:

an organic semiconductor layer containing at least porphyrin; and
a layer composed of at least a polysiloxane compound, the layer beinglaminated on the organic semiconductor layer so as to be in intimate contact with the
organic semiconductor layer consisting essentially of a silsesquioxane compound
represented by the following general formula (2):



where R_7 to R_{10} each represents a substituted or unsubstituted alkyl or alkenyl group having 1 to 5 carbon atoms, or a substituted or unsubstituted phenyl group; R_7 to R_{10} may be identical to or different from one another; m and n each represents an integer of 0 or more; and a sum of m and n is an integer of 1 or more.

 (Currently Amended) The field effect transistor according to any one of claims 1 to 3 claim 3, wherein the porphyrin is represented by the following general formula (3):

(In the formula; where R_{II}'s represent at least one kind selected from the group consisting of a hydrogen atom, a halogen atom, a hydroxyl group, or an alkyl, oxyalkyl, thioalkyl, or alkylester group having 1 to 12 carbon <u>atoms</u>; atoms, and R_{II}'s may be identical to or different from one another. In addition; <u>another</u>; adjacent R_{II}'s may form an aromatic ring which may have a <u>substituent. In addition</u>; <u>substituent</u>; the adjacent R_{II}'s may be connected to another porphyrin ring which may have a substituent through the formed aromatic <u>ring</u>; <u>ring</u>; R_{I2}'s represent at least one kind selected from the group consisting of a hydrogen atom and an aryl group which may have a <u>substituent</u>; R_{I2}'s may be

identical to or different from one another; <u>another;</u> and X represents a hydrogen atom or a metal atom;) atom.

- (Currently Amended) The field effect transistor according to any one of claims 1 to 4 claim 4, wherein at least one pair of the adjacent R₁₁'s in the general formula
 forms an aromatic ring.
- 6. (Currently Amended) The field effect transistor according to any one of claims 1 to 5 claim 5, wherein the aromatic ring formed by the at least one pair of the adjacent R₁₁'s in the general formula (3) is obtained by heating a precursor having a bicyclo [2.2.2] octadiene skeleton structure which may have a substituent.
- 7. (Currently Amended) The A field effect transistor according to any one of claims 1 to 6; having an organic semiconductor layer, comprising:

an organic semiconductor layer containing at least porphyrin; and

a layer composed of at least a polysiloxane compound, the layer being

laminated on the organic semiconductor layer so as to be in intimate contact with the

organic semiconductor layer.

wherein Bragg angles (20) of $CuK\alpha$ X-ray diffraction in the organic semiconductor layer have peaks at $8.3^{\circ} \pm 0.2^{\circ}$, $10.1^{\circ} \pm 0.2^{\circ}$, $11.8^{\circ} \pm 0.2^{\circ}$, and $14.4^{\circ} \pm 0.2^{\circ}$.

8. (Currently Amended) The A field effect transistor according to any one

of claims 1 to 6, having an organic semiconductor layer, comprising:

organic semiconductor layer,

an organic semiconductor layer containing at least porphyrin; and
a layer composed of at least a polysiloxane compound, thelayer being
laminated on the organic semiconductor layer so as to be in intimate contact with the

wherein Bragg angles (2 θ) of CuK α X-ray diffraction in the organic semiconductor layer have peaks at 8.4° \pm 0.2°, 11.9° \pm 0.2°, and 16.9° \pm 0.2°.

 (Currently Amended) The A field effect transistor according to any one of claims 1 to 6; having an organic semiconductor layer, comprising;

an organic semiconductor layer containing at least porphyrin; and
a layer composed of at least a polysiloxane compound, the layer being
laminated on the organic semiconductor layer so as to be in intimate contact with the
organic semiconductor layer.

wherein Bragg angles (20) of CuK α X-ray diffraction in the organic semiconductor layer have peaks at 7.2° \pm 0.2°, 7.8° \pm 0.2°, 11.7° \pm 0.2°, and 23.5° \pm 0.2°.

10. (Currently Amended) The A field effect transistor according to any one of claims 1 to 6; having an organic semiconductor layer, comprising:

an organic semiconductor layer containing at least porphyrin; and

a layer composed of at least a polysiloxane compound, the layer being laminated on the organic semiconductor layer so as to be in intimate contact with the

organic semiconductor layer,

wherein Bragg angles (20) of CuK α X-ray diffraction in the organic semiconductor layer have peaks at 7.3° \pm 0.2°, 7.8° \pm 0.2°, 11.7° \pm 0.2°, and 19.6° \pm 0.2°.

11 to 37. (Cancelled)